


<b>Search Notes</b>  	<b>Application/Control No.</b>  10555664	<b>Applicant(s)/Patent Under Reexamination</b>  ASSAF ET AL.
	<b>Examiner</b>  Loewe, Sun Jae Y	<b>Art Unit</b>  1626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
restriction requirement	10/1/2007	sl
stn structure: registry & caplus	12-28-2007	sl
palm all inventors	12-28-2007	sl
STN: registry & caplus updated	9-29-2008	sl
PALM all inventor updated	9-29-08	sl
STN registry & caplus updated	5-5-2009	sl
PALM all inventors updated	5-5-2009	sl
STN registry & caplus updated	12-4-2009	sl
PALM all inventors updated	12-4-2009	sl
STN registry&cplus updated	8-5-2010	sl
PALM all inventors updated	8-5-2010	sl
STN registry&cplus updated	12-27-2010	sl
PALM all inventors updated	12-27-2010	sl
patentability conference: R. Havlin, J. McKane	2-10-2011	sl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
514	365	2-10-2011	sl
548	202	2-10-2011	sl

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